

DOSEMI

IGBT

DG160X07T2

650V/160A IGBT with Diode

General Description

DOSEMI IGBT Power Discrete provides ultra low conduction loss as well as low switching loss. They are designed for the applications such as general inverters and UPS.

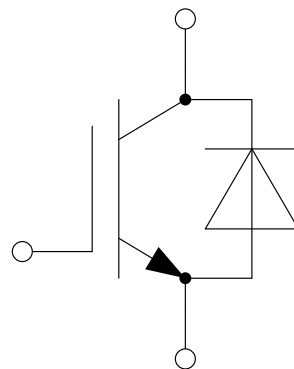
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- Low switching loss
- Maximum junction temperature 175°C
- $V_{CE(sat)}$ with positive temperature coefficient
- Fast & soft reverse recovery anti-parallel FWD

Typical Applications

- Inverter for motor drive
- AC and DC servo drive amplifier
- Uninterruptible power supply

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	650	V
V_{GES}	Gate-Emitter Voltage Transient Gate-Emitter Voltage	± 20 -25/+30	V
I_C	Collector Current @ $T_C=25^\circ\text{C}$ Value limited by bondwire @ $T_C=100^\circ\text{C}$	200 ⁽¹⁾ 160	A
I_{CM}	Pulsed Collector Current t_p limited by T_{jmax}	480	A
P_D	Maximum Power Dissipation @ $T_j=175^\circ\text{C}$	1079	W

Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	650	V
I_F	Diode Continuous Forward Current @ $T_C=25^\circ\text{C}$ Value limited by bondwire @ $T_C=90^\circ\text{C}$	200 ⁽¹⁾ 160	A
I_{FM}	Diode Maximum Forward Current t_p limited by T_{jmax}	480	A

Discrete

Symbol	Description	Values	Unit
T_{jop}	Operating Junction Temperature(IGBT) Operating Junction Temperature(Diode)	-40 to +175 -40 to +150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to +150	$^\circ\text{C}$
T_S	Soldering Temperature, 1.6mm from case for 10s	260	$^\circ\text{C}$

(1) Value limited by bondwire

IGBT Characteristics $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=160\text{A}, V_{GE}=15\text{V}, T_j=25^\circ\text{C}$		1.55	2.00	V
		$I_C=160\text{A}, V_{GE}=15\text{V}, T_j=150^\circ\text{C}$		1.80		
		$I_C=160\text{A}, V_{GE}=15\text{V}, T_j=175^\circ\text{C}$		1.90		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=2.56\text{mA}, V_{CE}=V_{GE}, T_j=25^\circ\text{C}$	5.0	5.8	6.5	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$			200	μA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^\circ\text{C}$			100	nA
R_{Gint}	Internal Gate Resistance			0		Ω
C_{ies}	Input Capacitance			17.2		nF
C_{oes}	Output Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		0.79		nF
C_{res}	Reverse Transfer Capacitance			0.47		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		0.89		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=160\text{A}, R_G=5\Omega, V_{GE}=-8/+15\text{V}, L_S=40\text{nH}, T_j=25^\circ\text{C}$		60		ns
t_r	Rise Time			297		ns
$t_{d(off)}$	Turn-Off Delay Time			214		ns
t_f	Fall Time			84		ns
E_{on}	Turn-On Switching Loss			17.1		mJ
E_{off}	Turn-Off Switching Loss			4.06		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=160\text{A}, R_G=5\Omega, V_{GE}=-8/+15\text{V}, L_S=40\text{nH}, T_j=150^\circ\text{C}$		64		ns
t_r	Rise Time			324		ns
$t_{d(off)}$	Turn-Off Delay Time			239		ns
t_f	Fall Time			126		ns
E_{on}	Turn-On Switching Loss			20.1		mJ
E_{off}	Turn-Off Switching Loss			5.21		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=160\text{A}, R_G=5\Omega, V_{GE}=-8/+15\text{V}, L_S=40\text{nH}, T_j=175^\circ\text{C}$		65		ns
t_r	Rise Time			328		ns
$t_{d(off)}$	Turn-Off Delay Time			245		ns
t_f	Fall Time			145		ns
E_{on}	Turn-On Switching Loss			21.3		mJ
E_{off}	Turn-Off Switching Loss			5.82		mJ
I_{SC}	SC Data	$t_p \leq 6\mu\text{s}, V_{GE}=15\text{V}, T_j=150^\circ\text{C}, V_{CC}=400\text{V}, V_{CEM} \leq 650\text{V}$		800		A

Diode Characteristics $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=160\text{A}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$		1.70	2.15	V
		$I_F=160\text{A}, V_{GE}=0\text{V}, T_j=150^\circ\text{C}$		1.65		
t_{rr}	Diode Reverse Recovery Time	$V_R=400\text{V}, I_F=160\text{A},$ $-di/dt=480\text{A}/\mu\text{s}, V_{GE}=-8\text{V}$ $L_S=40\text{nH}, T_j=25^\circ\text{C}$		122		ns
Q_r	Recovered Charge			1.63		μC
I_{RM}	Peak Reverse Recovery Current			23.3		A
E_{rec}	Reverse Recovery Energy			0.53		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=400\text{V}, I_F=160\text{A},$ $-di/dt=470\text{A}/\mu\text{s}, V_{GE}=-8\text{V}$ $L_S=40\text{nH}, T_j=150^\circ\text{C}$		146		ns
Q_r	Recovered Charge			4.72		μC
I_{RM}	Peak Reverse Recovery Current			37.1		A
E_{rec}	Reverse Recovery Energy			1.29		mJ

Discrete Characteristics $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
R_{thJC}	Junction-to-Case (per IGBT)			0.139	K/W
	Junction-to-Case (per Diode)			0.252	
R_{thJA}	Junction-to-Ambient		40		K/W

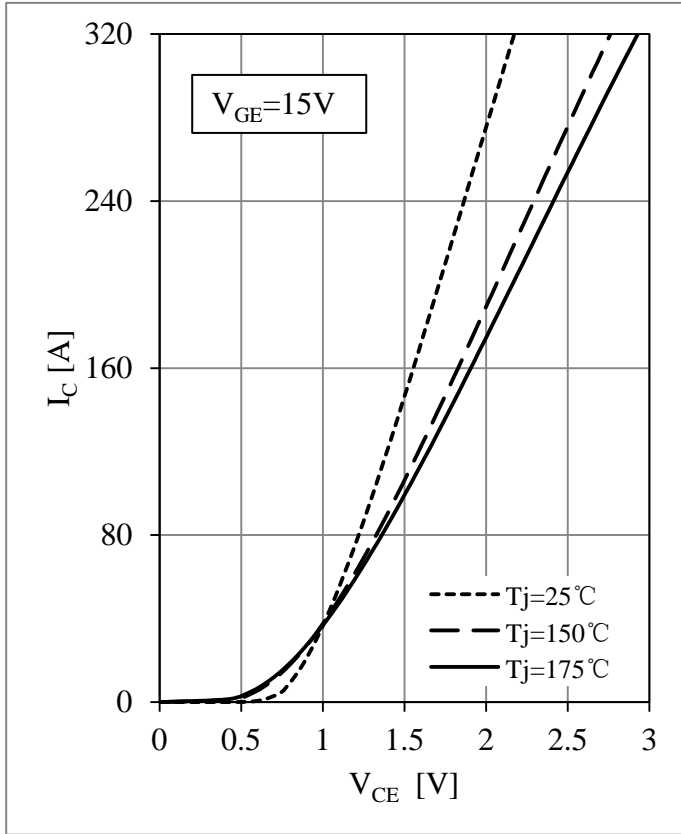


Fig 1. IGBT-inverter Output Characteristics

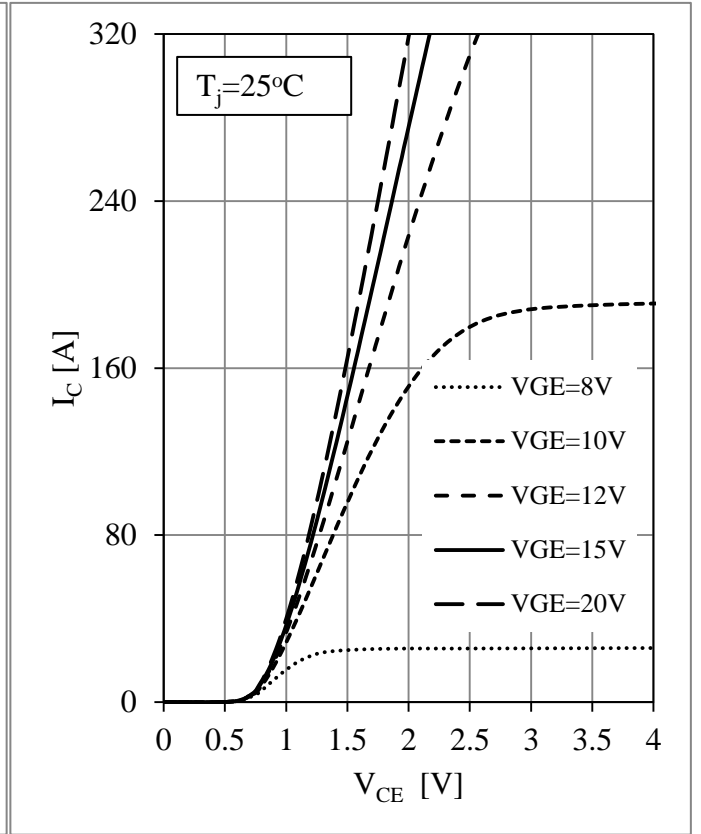


Fig 2. IGBT Output Characteristics

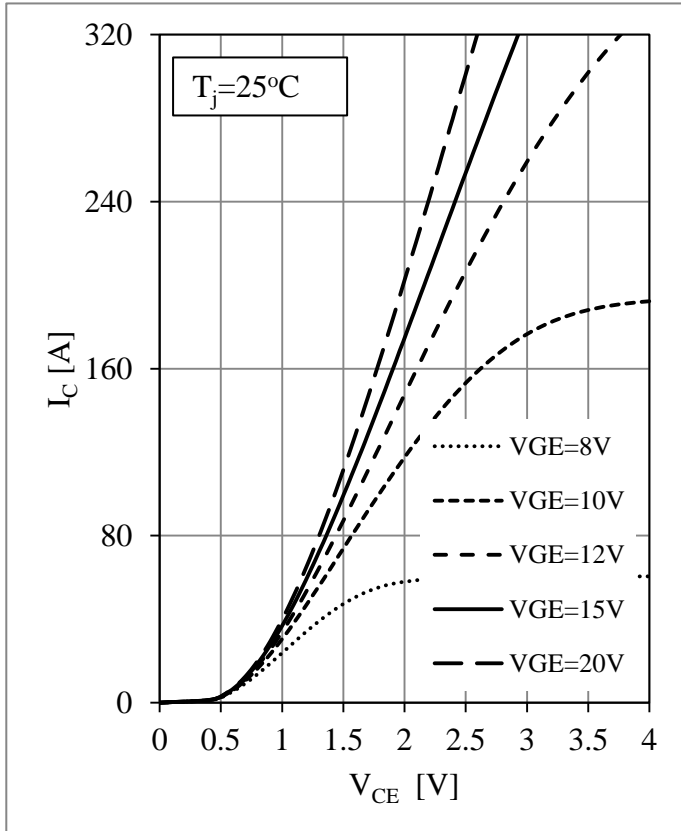


Fig 3. IGBT Output Characteristics

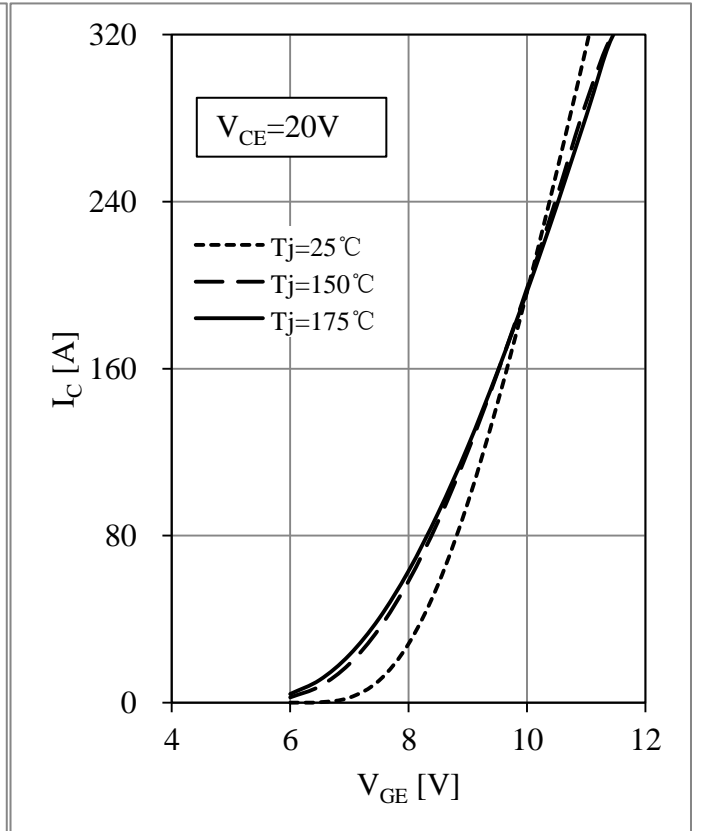


Fig 4. IGBT Transfer Characteristics

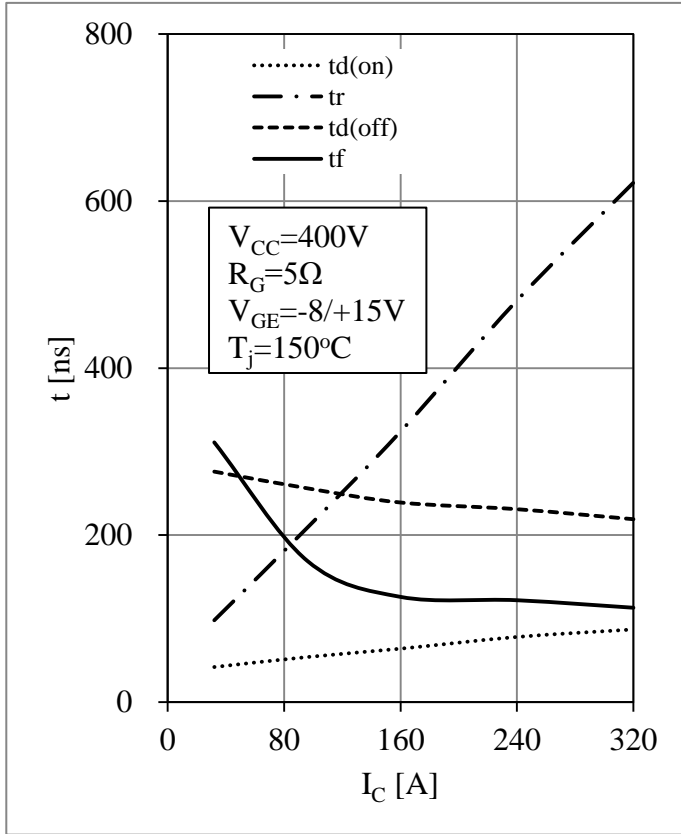


Fig 5. IGBT Switching Times as. I_C

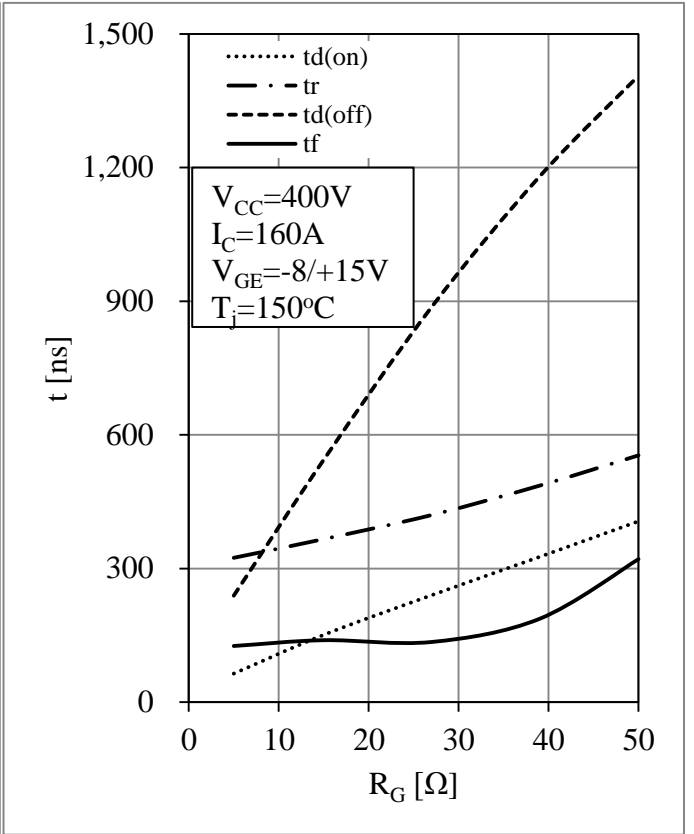


Fig 6. IGBT Switching Times as. R_G

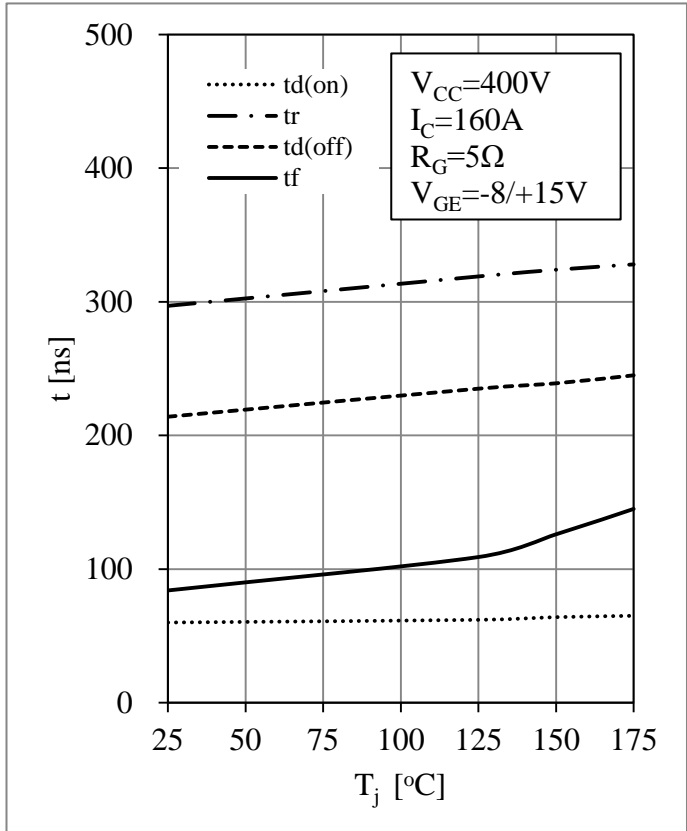


Fig 7. IGBT Switching Times vs. T_j

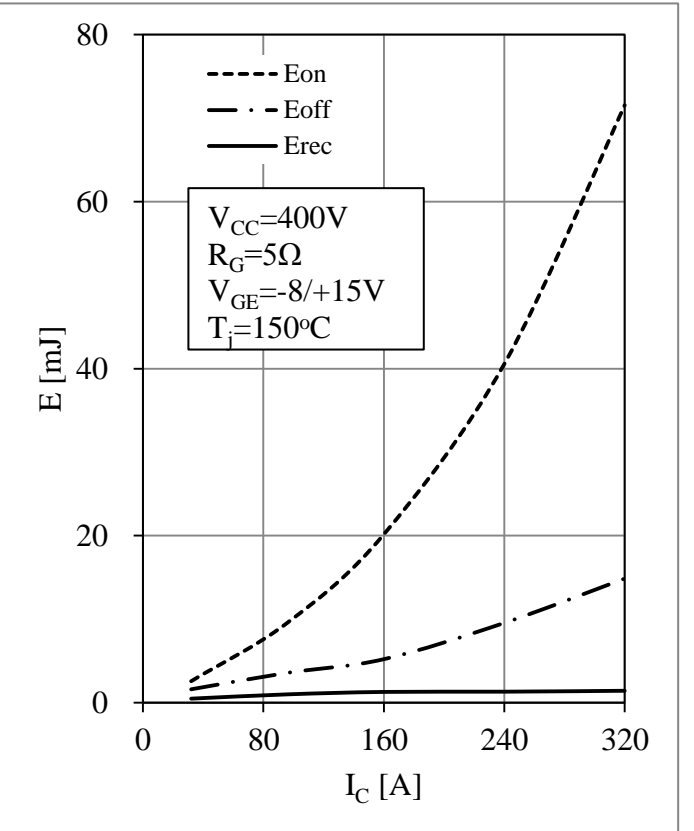


Fig 8. Switching Energy Loss vs. I_C

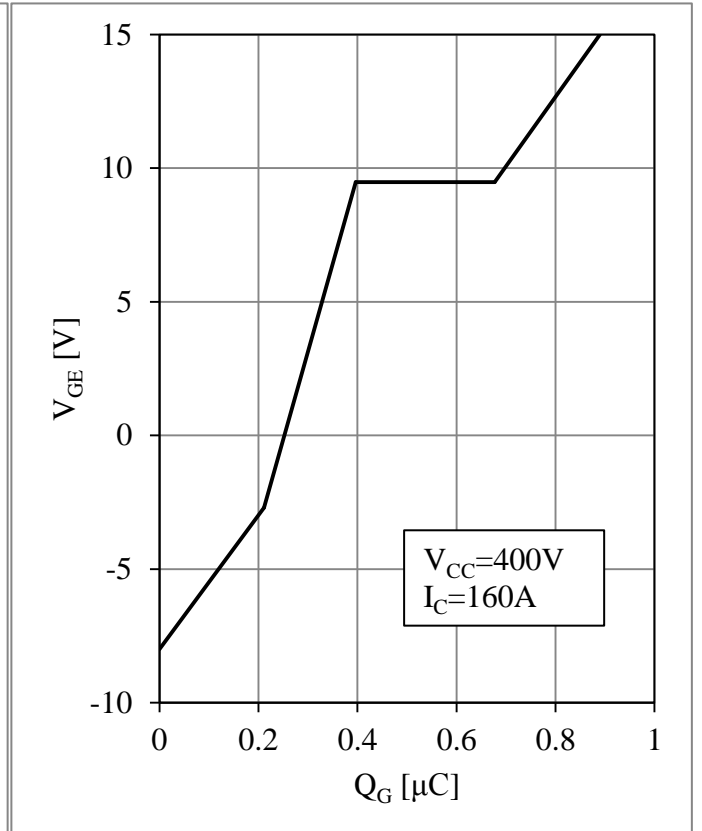
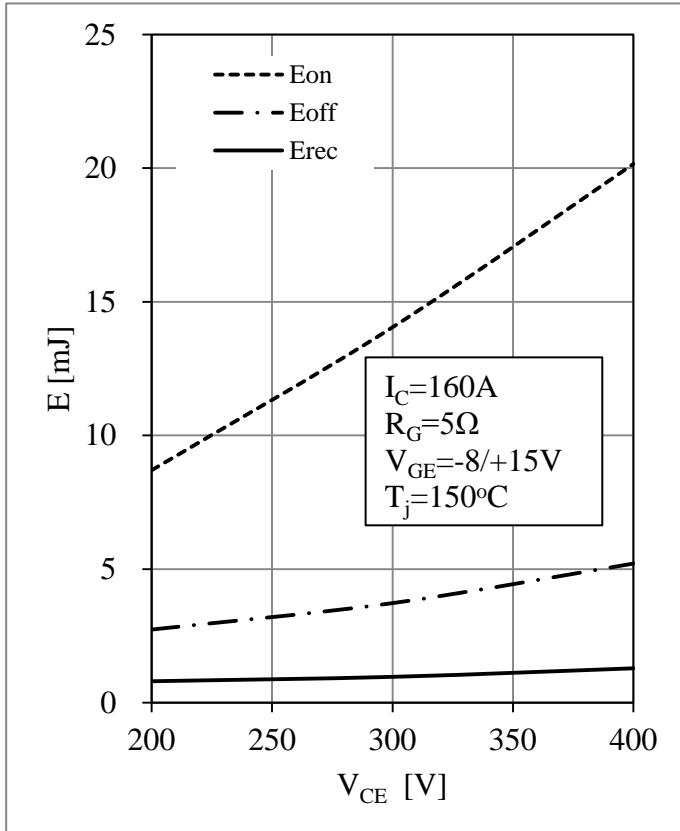
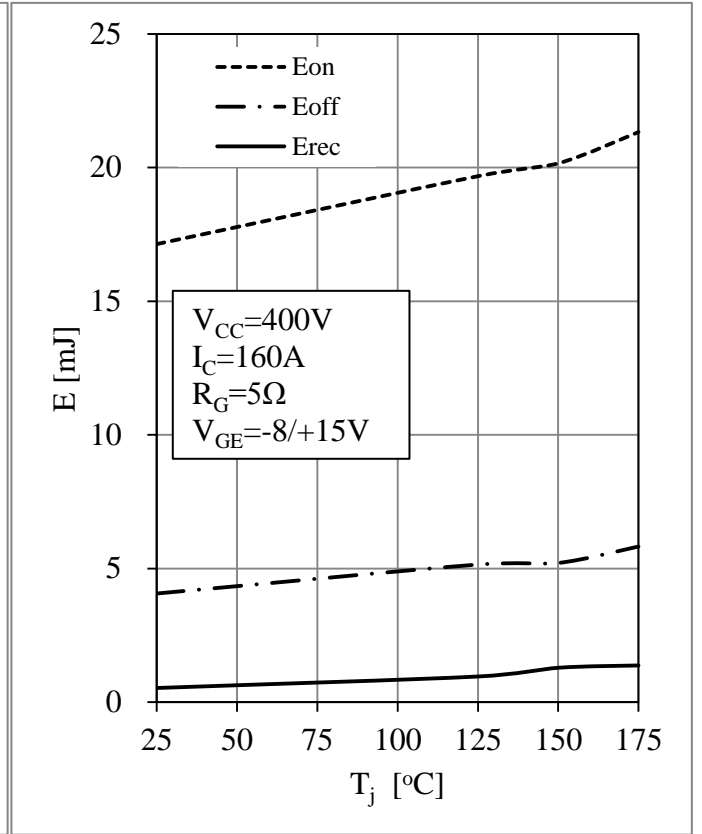
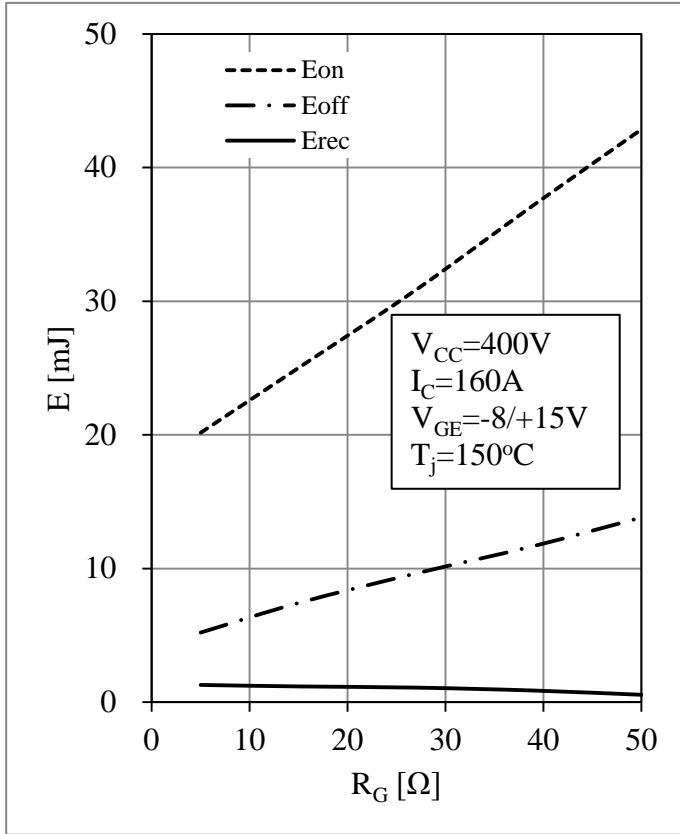


Fig 11. Switching Energy Loss vs. V_{CE}

Fig 12. IGBT Gate Charge Characteristic

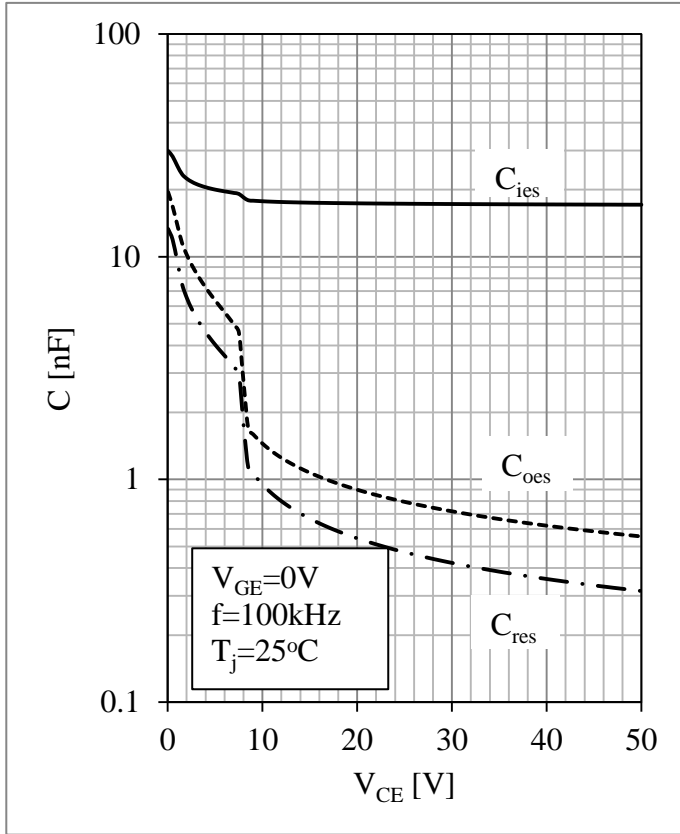


Fig 13. IGBT Capacity Characteristic

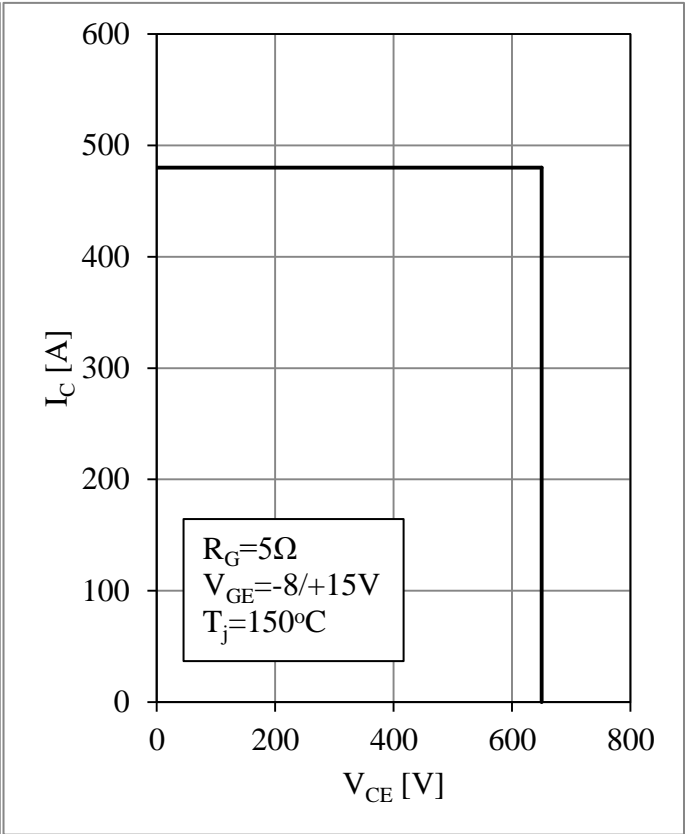


Fig 14. RBSOA

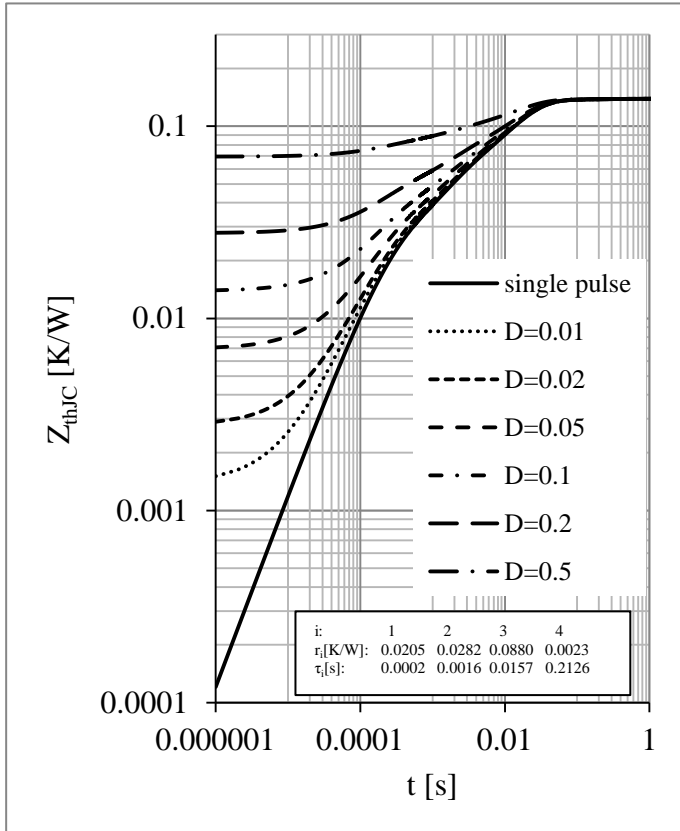


Fig 15. IGBT Transient Thermal Impedance

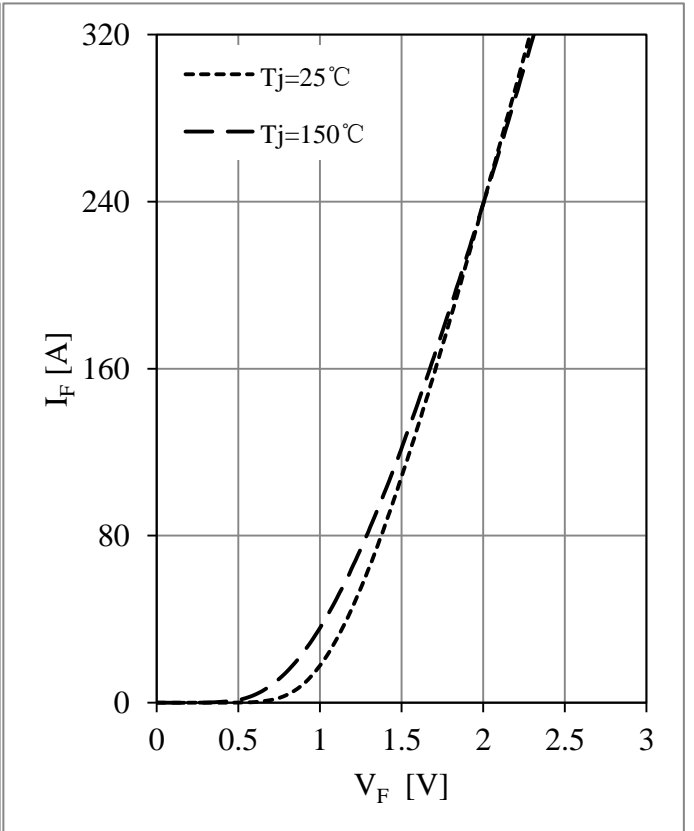


Fig 16. Diode Forward Characteristics

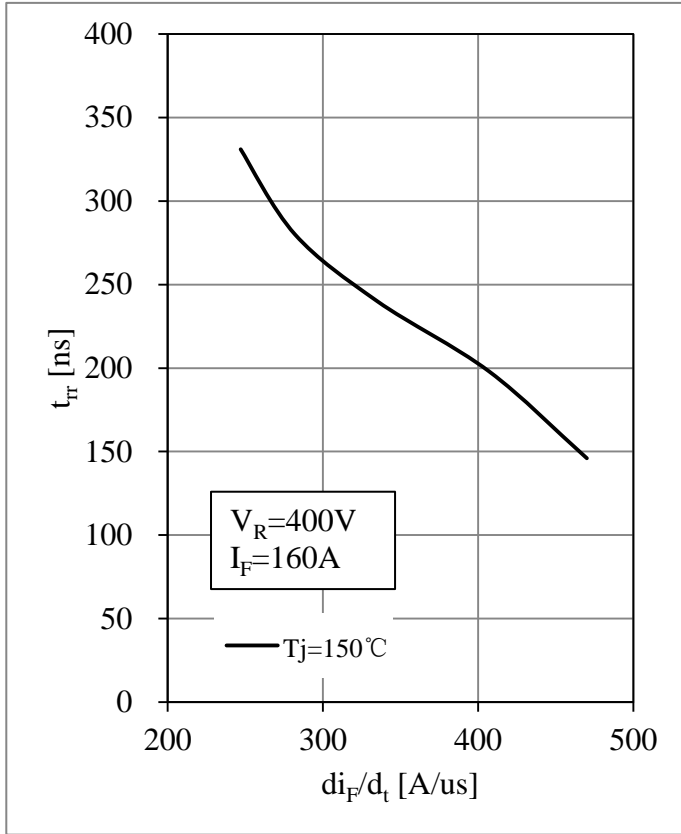


Fig 17. Reverse Recovery Time vs. di_F/d_t

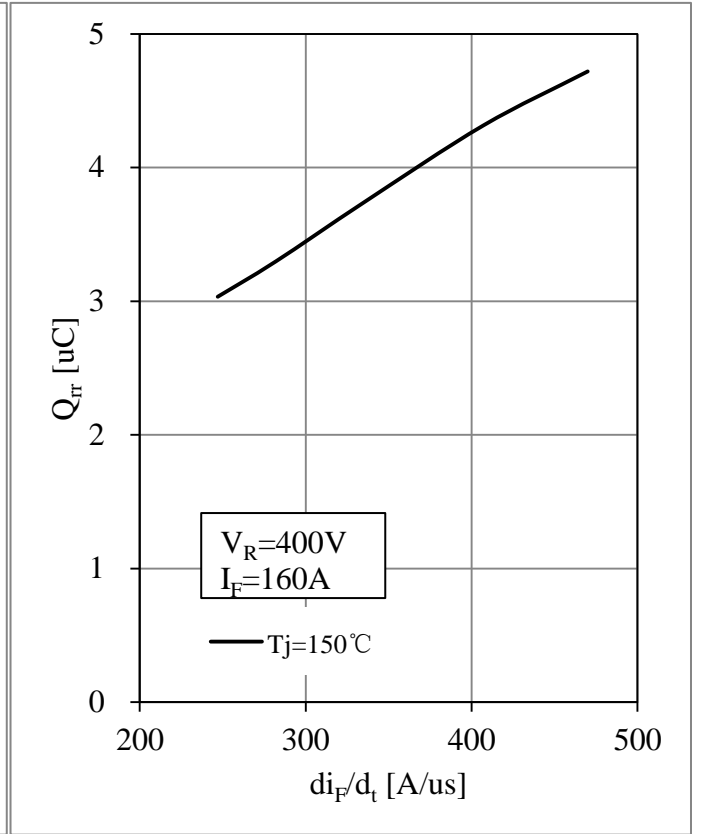


Fig 18. Reverse Recovery Charge vs. di_F/d_t

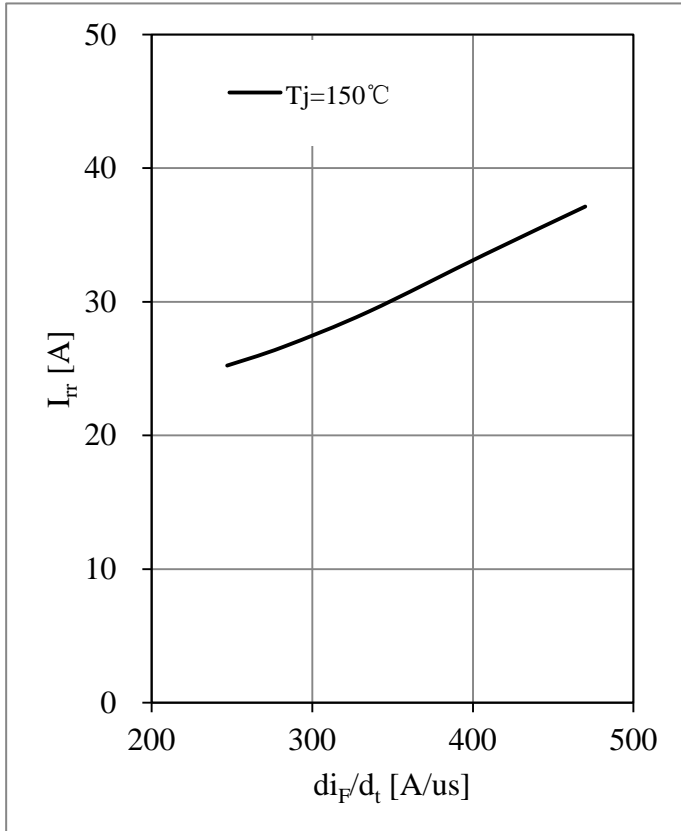


Fig 19. Reverse Recovery Current vs. di_F/d_t

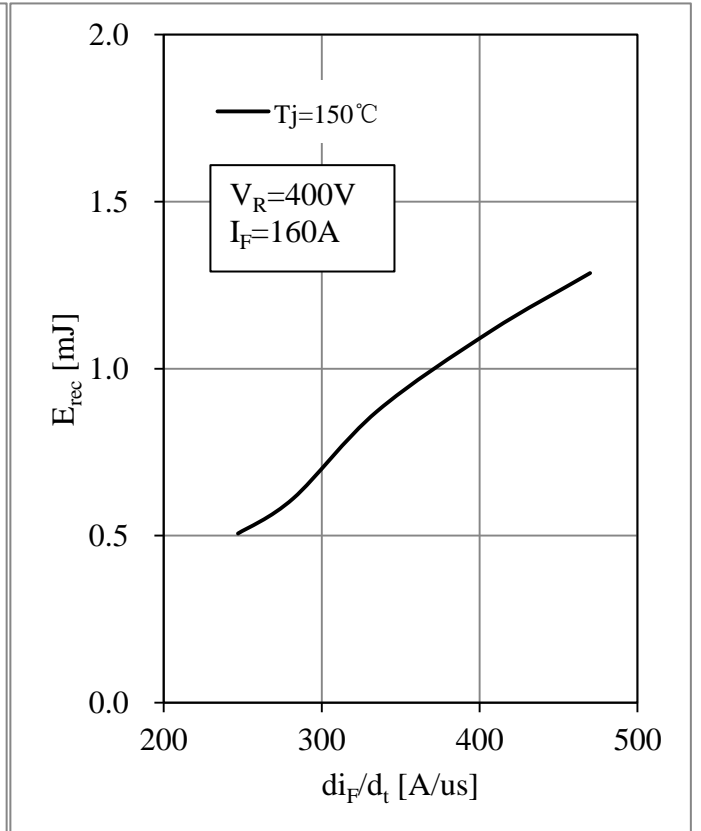


Fig 20. Reverse Energy Losses vs. di_F/d_t

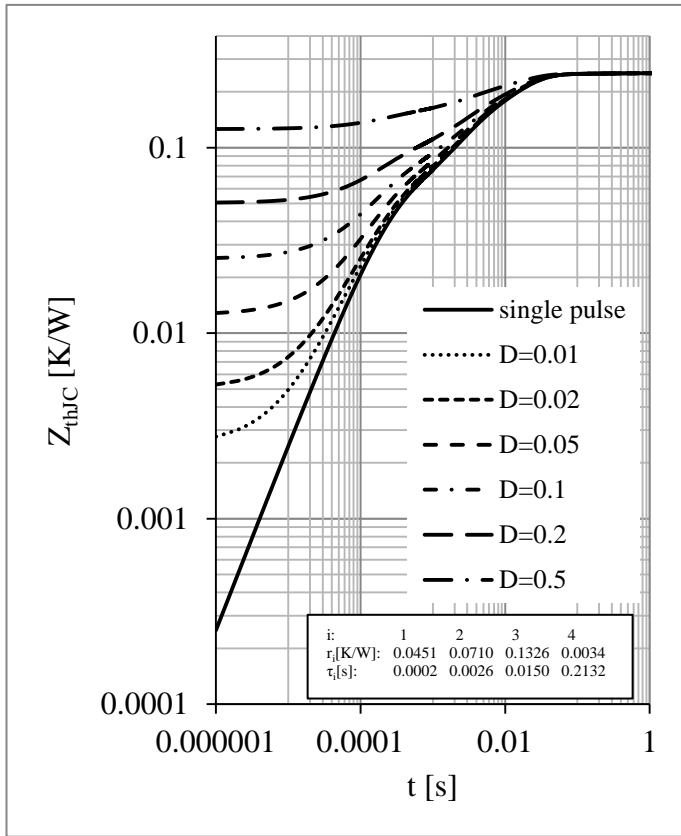


Fig 21. Diode Transient Thermal Impedance

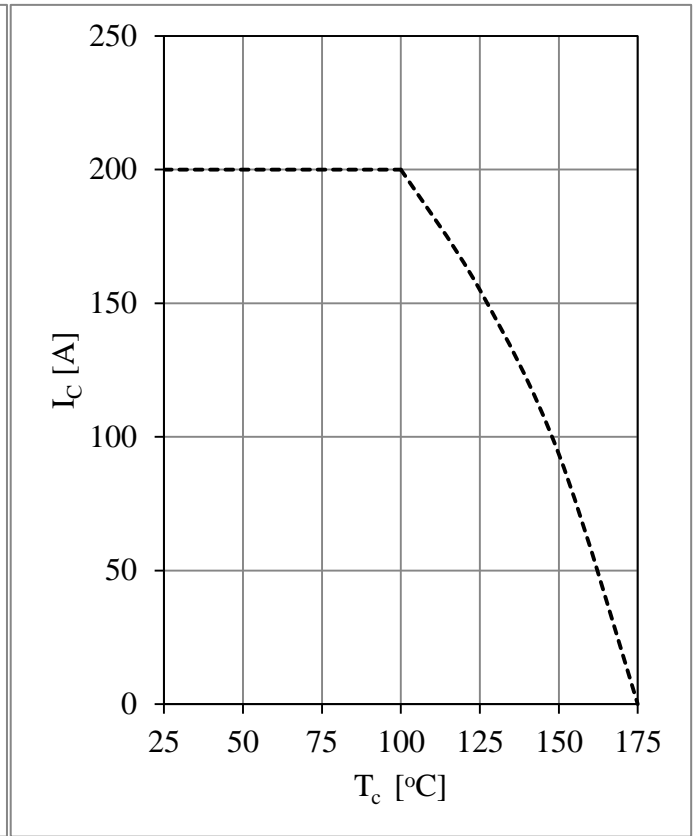
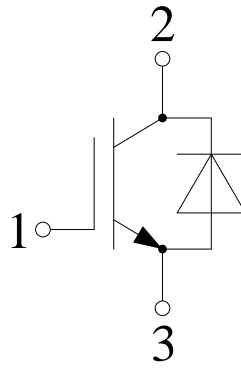


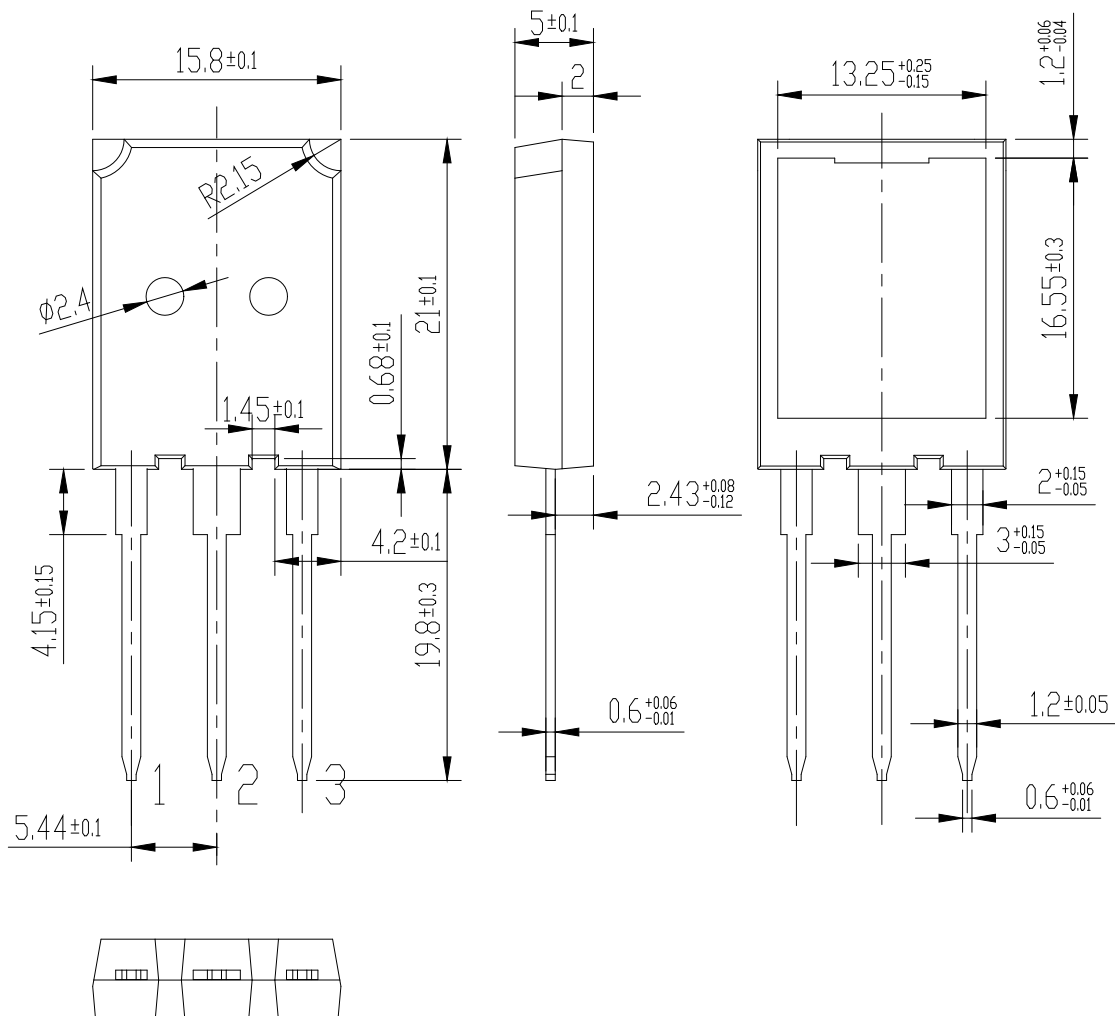
Fig 22. Collector Current vs. Tc

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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